

**Search Notes**

Application/Control No.

10/766,660

Examiner

David E. Martinez

Applicant(s)/Patent under  
Reexamination

CARNAHAN ET AL.

Art Unit

2181

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East see attached	11/28/2006	DM
710/62,63,72.ccls. with keywords and text search	11/28/2006	DM
inventor search edan	11/28/2006	DM
Databases: US Patents, US PGPUBS, USOCR, EPO Derwent, IBM_TDB.	11/28/2006	DM